Power MOSFET

30 V, 74 A, Single N-Channel, SO-8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Para	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Volt	Gate-to-Source Voltage			±20	V
Continuous Drain Current R _{θJA}		T _A = 25°C	I _D	16	Α
(Note 1)		T _A = 85°C		11.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.2	W
Continuous Drain		T _A = 25°C	ID	10	Α
Current R _{θJA} (Note 2)	Steady	T _A = 85°C		7	
Power Dissipation R _{0JA} (Note 2)	State	T _A = 25°C	P _D	0.88	W
Continuous Drain		T _C = 25°C	I _D	74	Α
Current R _{0JC} (Note 1)		T _C = 85°C		53	
Power Dissipation R ₀ JC (Note 1)		T _C = 25°C	P _D	47.2	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	148	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			I _S	39	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 30 V, V_{GS} = 10 V, I_L = 22 A_{pk} , L = 1.0 mH, R_G = 25 Ω)			EAS	242	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

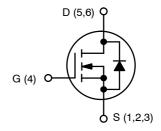
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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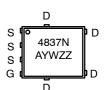
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
2014	5.0 mΩ @ 10 V	
30 V	7.5 mΩ @ 4.5 V	74 A



N-CHANNEL MOSFET



SO-8 FLAT LEAD CASE 488AA STYLE 1



MARKING DIAGRAM

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4837NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4837NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.65	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	56.75	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	142.2	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS	•	•					•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				25		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $T_{J} = 25 ^{\circ}\text{C}$				1		
		V _{DS} = 24 V	T _J = 125°C			10	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA	
ON CHARACTERISTICS (Note 3)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.5		2.5	V	
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.7		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V to	I _D = 30 A		3.5	5.0		
		11.5 V	I _D = 15 A		3.5		1 '	
		V _{GS} = 4.5 V	I _D = 30 A		5.9	7.5	mΩ	
			I _D = 15 A		5.9			
Forward Transconductance	9FS	V _{DS} = 15 V, I _D = 15 A			15		S	
CHARGES AND CAPACITANCES	•						•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 12 V			2048		pF	
Output Capacitance	C _{OSS}				444			
Reverse Transfer Capacitance	C _{RSS}				239			
Total Gate Charge	Q _{G(TOT)}				14.2	22		
Threshold Gate Charge	Q _{G(TH)}				2.98		nC	
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 1$	5 V; I _D = 30 A		5.7			
Gate-to-Drain Charge	Q_{GD}				6.7			
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, V _{DS} = 15 V; I _D = 15 A			34.2		nC	
SWITCHING CHARACTERISTICS (Note 4)								
Turn-On Delay Time	t _{d(ON)}				14.2			
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15	5 V. In = 15 A.		55		1	
Turn-Off Delay Time	t _{d(OFF)}	$R_{\rm G} = 3.0 \Omega$			19		ns	
Fall Time	t _f				10		1	
Turn-On Delay Time	t _{d(ON)}				8.5			
Rise Time	t _r	V_{GS} = 11.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			25.6		1	
Turn-Off Delay Time	t _{d(OFF)}				25.2		ns	
Fall Time	t _f				9.2			

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

^{3.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$		0.85	1.2	.,	
			T _J = 125°C		0.72		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s,}$ $I_S = 30 \text{ A}$			24		ns
Charge Time	ta				13		
Discharge Time	t _b				11		
Reverse Recovery Charge	Q _{RR}				14		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	T _A = 25°C			0.93		nΗ
Drain Inductance	L _D				0.005		
Gate Inductance	L _G				1.84		
Gate Resistance	R_{G}				2.8		Ω

- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching characteristics are independent of operating junction temperatures.

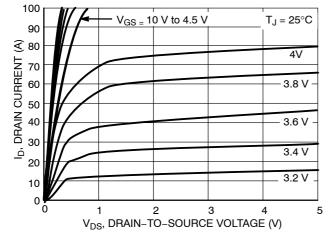


Figure 1. On-Region Characteristics

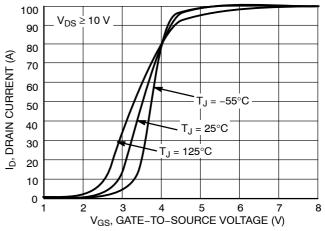


Figure 2. Transfer Characteristics

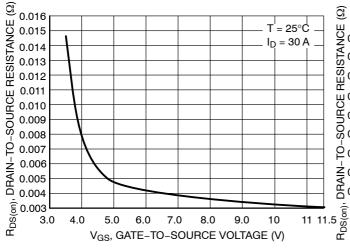


Figure 3. On–Resistance vs. V_{GS}

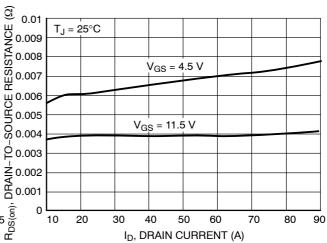


Figure 4. On-Resistance vs. Drain Current & Gate Voltage

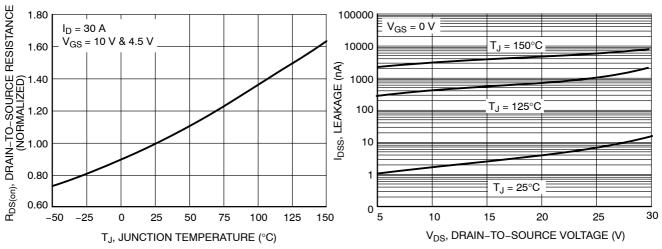


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

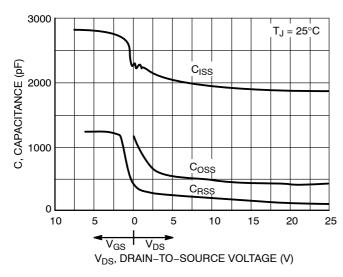


Figure 7. Capacitance Variation

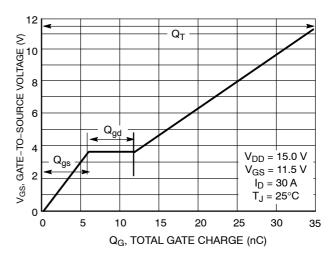


Figure 8. Gate-to-Source & Drain-to-Source Voltage vs. Total Charge

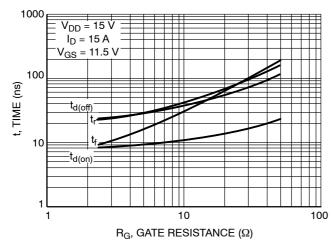


Figure 9. Resistive Switching Time Variation vs.

Gate Resistance

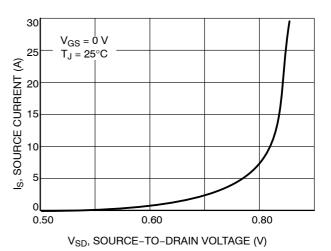


Figure 10. Diode Forward Voltage vs. Current

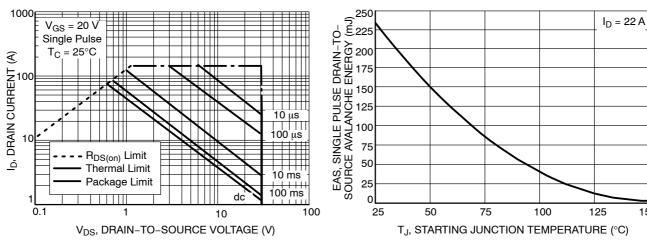


Figure 11. Maximum Rated Forward-Biased Safe Operating Range

Figure 12. Maximum Avalanche Energy vs, Starting Junction Temperature

150

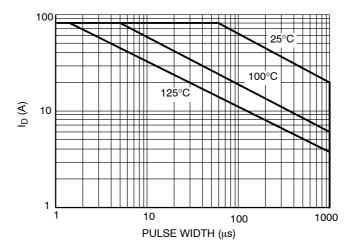


Figure 13. EAS vs. Pulse Width



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е		1.27 BSC	;	
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
М	3.00	3.40	3.80	
A	0 0		12 °	

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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